

Vishay Siliconix

N-Channel 25-V (D-S) MOSFET

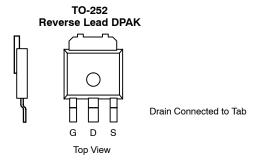
PRODUCT SUMMARY					
V _{DS} (V)	$r_{DS(on)}$ (Ω)	I _D (A) ^{a, e}	Q _g (Typ)		
25	0.0062 @ V _{GS} = 10 V	78	. 20.5 nC		
	0.010 @ V _{GS} = 4.5 V	62			

FEATURES

- TrenchFET® Power MOSFET
- 100% R_g Tested
- RoHS Compliant

APPLICATIONS

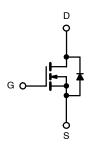
- DC/DC Conversion, Low-Side
 - Desktop PC



Ordering Information:

SUR50N025-06P-E3 (Lead (Pb)-Free)

SUR50N025-06P-T4—E3 (Lead (Pb)-Free, alternate tape orientation)



N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	25	V	
Gate-Source Voltage		V_{GS}	±20		
	T _C = 25°C		78 ^{a, e}		
	T _C = 70°C		65 ^{a, e}		
Continuous Drain Current (T _J = 175°C)	T _A = 25°C	I _D	32 b, c		
	T _A = 70°C		25 ^{b, c}		
Pulsed Drain Current		I _{DM}	100	A	
Continuous Source-Drain Diode Current	T _C = 25°C		43		
Continuous Source-Drain Diode Current	T _A = 25°C	ls	7.1 ^{b, c}		
Avalanche Current Pulse		I _{AS}	35		
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	61.25	mJ	
	T _C = 25°C		65 ^a		
Mandanian Danisa Disabatian	T _C = 70°C		45 ^a	,,,	
Maximum Power Dissipation	T _A = 25°C	P _D	10.7 ^{b, c}	W	
	T _A = 70°C		7.5 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	-55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 sec	R _{thJA}	11	14	2044	
Maximum Junction-to-Case	Steady State	R _{thJC}	1.9	2.3	°C/W	

Notes:

- a. Based on $T_C = 25^{\circ}C$.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 sec
- d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 50 A.

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New Product



SPECIFICATIONS ($T_J = 25^{\circ}C$ UNLESS OTHERWISE NOTED)								
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit		
Static								
Drain-Source Breakdown Voltage	V_{DS}	V_{GS} = 0 V, I_D = 250 μA	25			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		20				
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$		-5.5		mV/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.4		2.4	V		
Gate-Source Leakage	I _{GSS}	V_{DS} = 0 V, V_{GS} = ± 20 V			±100	nA		
Zero Gate Voltage Drain Current	I _{DSS} _	V _{DS} = 25 V, V _{GS} = 0 V			1	† .		
		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55^{\circ}\text{C}$			10	μΑ		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	50			Α		
	r _{DS(on)}	V _{GS} = 10 V, I _D = 20 A		0.0051	0.0062	Ω		
Drain-Source On-State Resistance ^a		V _{GS} = 4.5 V, I _D = 15 A		0.0081	0.010			
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 15 \text{ A}$		55		S		
Dynamic ^b			•					
Input Capacitance	C _{iss}		Τ	2490		pF		
Output Capacitance	C _{oss}	V _{DS} = 12 V, V _{GS} = 0 V, f = 1 MHz		530				
Reverse Transfer Capacitance	C _{rss}			280				
		V _{DS} = 12 V, V _{GS} = 10 V, I _D = 50 A		44	66	nC		
Total Gate Charge	Q_g			20.5	31			
Gate-Source Charge	Q _{gs}	$V_{DS} = 12 \text{ V}, \ V_{GS} = 4.5 \text{ V}, \ I_{D} = 50 \text{ A}$		7.5				
Gate-Drain Charge	Q _{gd}			7.0				
Gate Resistance	R _g	f = 1 MHz	0.55	1.1	1.65	Ω		
Turn-On Delay Time	t _{d(on)}			19	28	-		
Rise Time	t _r	$V_{DD} = 12 \text{ V}, R_1 = 0.24 \Omega$		12	18			
Turn-Off Delay Time	t _{d(off)}	V_{DD} = 12 V, R_L = 0.24 Ω $I_D \cong$ 50 A, V_{GEN} = 4.5 V, R_g = 1 Ω		18	27			
Fall Time	t _f			7	11			
Turn-On Delay Time	t _{d(on)}			9	14	ns		
Rise Time	t _r	$V_{DD} = 12 \text{ V}, R_{L} = 0.24 \Omega$		11	16.5	1 		
Turn-Off Delay Time	t _{d(off)}	V_{DD} = 12 V, R_L = 0.24 Ω I $_D$ \cong 50 A, V_{GEN} = 10 V, R_g = 1 Ω		24	36			
Fall Time	t _f			8	12			
Drain-Source Body Diode Characte	eristics							
Continuous Source-Drain Diode Current	I _S	T _C = 25°C			43	A		
Pulse Diode Forward Current ^a	I _{SM}				100	7 ^		
Body Diode Voltage	V _{SD}	I _S = 30 A		0.9	1.5	V		
Body Diode Reverse Recovery Time	t _{rr}			30	45	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25°C		20	30	nC		
Reverse Recovery Fall Time	t _a			13.5				
Reverse Recovery Rise Time	t _b			16.5		ns		

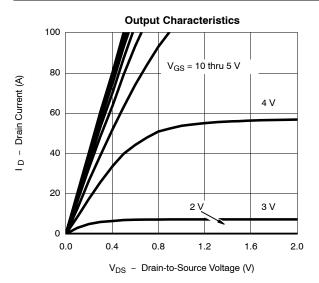
Notes

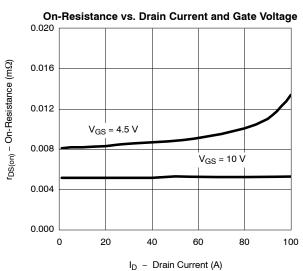
- Pulse test; pulse width $\leq 300 \, \mu s$, duty cycle $\leq 2\%$.
- Guaranteed by design, not subject to production testing.

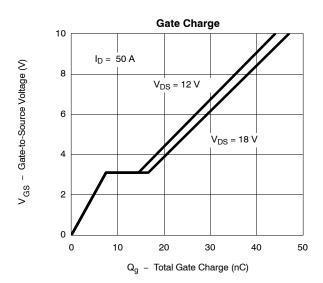
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

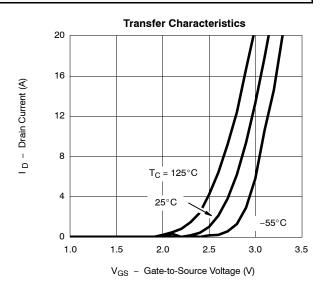


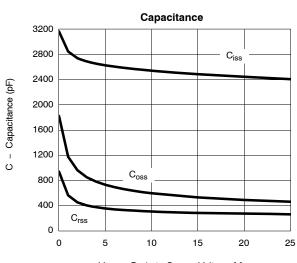
TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

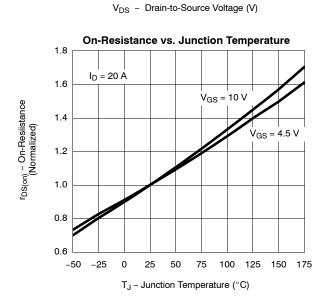






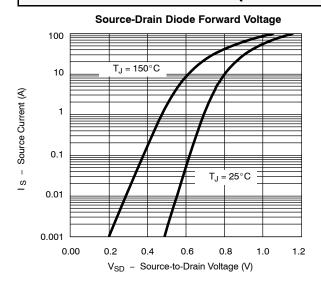


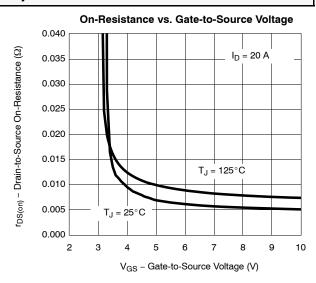


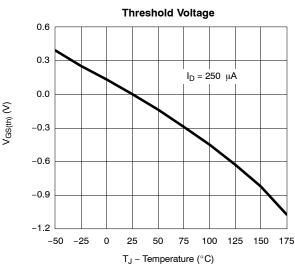


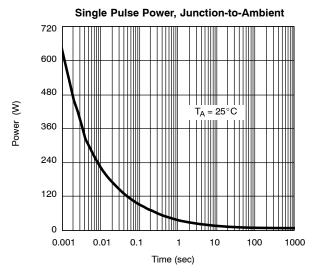


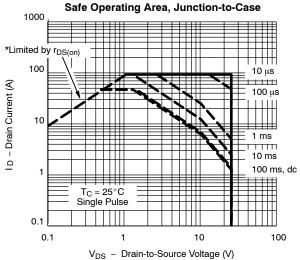
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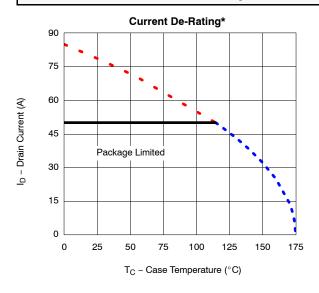


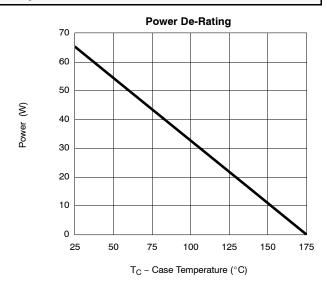


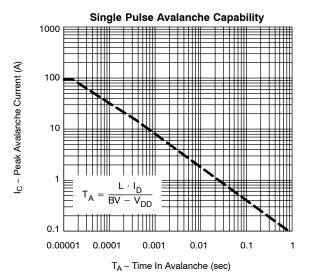


* V_{GS} > minimum V_{GS} at which $r_{DS(on)}$ is specified

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)



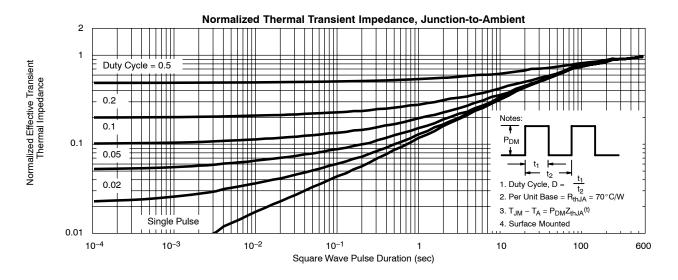


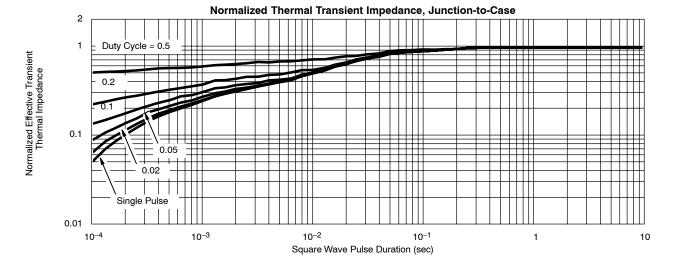


^{*}The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)





Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?73364.



Vishay

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